

Lists of structure factors, anisotropic displacement parameters, H-atom coordinates and complete geometry for (2) have been deposited with the IUCr (Reference: KA1074). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

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Acta Cryst. (1994). **C50**, 1801–1802

2,4,4-Trimethyl-2H-1,2-benzoselenazin-3(4H)-one

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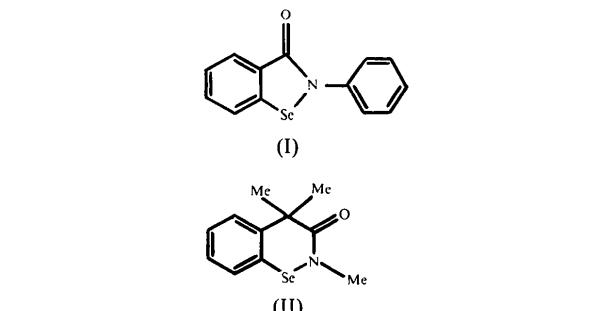
(Received 15 October 1993; accepted 8 February 1994)

Abstract

The title compound, $C_{11}H_{13}NOSe$, is a derivative of ebselen, an organoselenium compound which exhibits anti-inflammatory activity. The aim of the modification of the ebselen molecular structure is to increase the solubility of the compound without modifying the pharmacological properties. The Se—N bond [1.859 (5) Å] is included in a six-membered ring, which has a boat conformation. The value of the C—Se—N angle is 95.2 (2)°. The cohesion of the crystal is the result of van der Waals interactions.

Comment

Ebselen (Natterman/RP, 1981), (I), is an organoselenium compound which exhibits anti-inflammatory activity and has the ability to catalyze the reduction of hydroxyperoxidases by glutathion (Parnham & Graf, 1987). The crystal structure of ebselen has been determined previously (Dupont, Dideberg & Jacquemin, 1990). Some modifications of its molecular structure have been attempted in order to increase the solubility of the compound without modifying the pharmacological properties (Jacquemin, Christiaens, Renson, Evers & Dereu, 1992). In particular, a tetrahedral C has been introduced into the heterocycle to form the title compound (II), the crystal structure of which is described here. Fig. 1 shows the molecular structure, with the atomic numbering.



The transformation from the five-membered ring of ebselen to a six-membered heterocycle increases the N1—Sel—O1 angle by about 10°. The Sel—N1 and N1—C10 distances are shortened by about 0.04 Å. The substitution of the phenyl by a methyl group modifies the electronic delocalization around the N atom and this probably contributes to the deviations of the Se—N—(C=O) bond distances from those in ebselen. The benzene ring is planar to

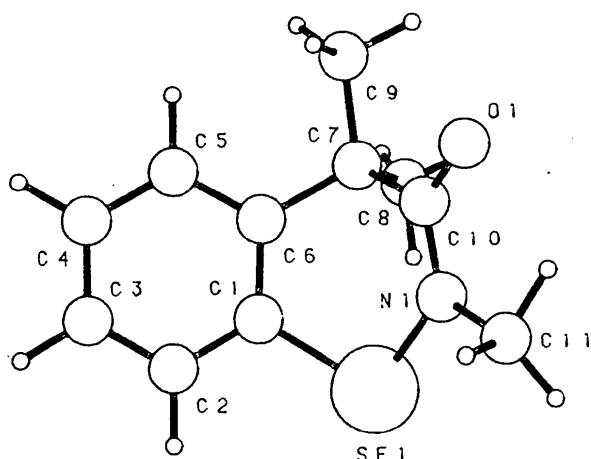


Fig. 1. View of the molecule with atom-labelling scheme.

within the 3σ limit. The atoms C1–C7 and Se1 are coplanar with a maximum atomic deviation from the mean plane of 0.050 (5) Å (C7). The internal dihedral angles of the heterocycle are characteristic of a boat conformation [puckering parameters $\theta = 91.7$ (4) $^\circ$ and $\varphi = 356.2$ (5) $^\circ$ (Cremer & Pople, 1975)]. The cohesion of the crystal is the result of van der Waals interactions. The short binding contact Se1···O1ⁱ [symmetry code: (i) $x, \frac{1}{2} - y, -\frac{1}{2} + z$; 3.376 (5) Å] is slightly shorter than the sum of the van der Waals radii of Se and O (≈ 3.5 Å).

Experimental

Crystal data

C ₁₁ H ₁₃ NOSe	Cu K α radiation
$M_r = 254.19$	$\lambda = 1.5418$ Å
Monoclinic	Cell parameters from 25 reflections
$P2_1/c$	$\theta = 37.5\text{--}42.1^\circ$
$a = 8.410$ (1) Å	$\mu = 5.07$ mm $^{-1}$
$b = 13.762$ (1) Å	$T = 290$ K
$c = 9.530$ (1) Å	Prism
$\beta = 105.57$ (11) $^\circ$	0.6 \times 0.5 \times 0.3 mm
$V = 1062.5$ (1) Å 3	Colourless
$Z = 4$	Crystal source: from cyclohexane solution
$D_x = 1.588$ Mg m $^{-3}$	

Data collection

Siemens diffractometer	$R_{\text{int}} = 0.02$
ω scans	$\theta_{\text{max}} = 55.0^\circ$
Absorption correction:	$h = -8 \rightarrow 8$
empirical	$k = 0 \rightarrow 14$
$T_{\text{min}} = 0.14$, $T_{\text{max}} = 0.37$	$l = 0 \rightarrow 10$
1504 measured reflections	2 standard reflections
1334 independent reflections	frequency: 60 min
1162 observed reflections	intensity variation: 4–8%
[$I \geq 2.5\sigma(I)$]	

Refinement

Refinement on F	$(\Delta/\sigma)_{\text{max}} = 0.1$
$R = 0.075$	$\Delta\rho_{\text{max}} = 0.5$ e Å $^{-3}$
$wR = 0.070$	$\Delta\rho_{\text{min}} = -0.5$ e Å $^{-3}$
$S = 0.63$	Atomic scattering factors
1162 reflections	from <i>International Tables for X-ray Crystallography</i> (1974, Vol. IV)
138 parameters	
Only H-atom U 's refined	
$w = 1/[\sigma^2(F_o) + 0.02557F_o^2]$	

Table 1. Fractional atomic coordinates and equivalent isotropic displacement parameters (Å 2)

$$B_{\text{eq}} = (8\pi^2/3)\sum_i\sum_j U_{ij}a_i^*a_j^*\mathbf{a}_i\cdot\mathbf{a}_j$$

	x	y	z	B_{eq}
C1	-0.0272 (6)	0.3096 (4)	0.1274 (6)	3.2 (1)
C2	-0.1914 (8)	0.2790 (5)	0.0879 (7)	4.0 (2)
C3	-0.3060 (7)	0.3295 (5)	0.1444 (6)	4.0 (2)
C4	-0.2556 (7)	0.4053 (5)	0.2368 (6)	4.4 (2)
C5	-0.0932 (6)	0.4363 (4)	0.2733 (6)	3.7 (2)
C6	0.0246 (6)	0.3902 (4)	0.2168 (5)	2.8 (1)
C7	0.2050 (6)	0.4268 (4)	0.2503 (5)	2.9 (1)
C8	0.2393 (3)	0.4722 (5)	0.1128 (7)	4.3 (2)

C9	0.2448 (8)	0.5027 (5)	0.3712 (7)	4.6 (2)
C10	0.3214 (7)	0.3386 (4)	0.2995 (6)	3.1 (1)
C11	0.4083 (8)	0.1732 (5)	0.2662 (7)	4.4 (2)
N1	0.3040 (7)	0.2607 (3)	0.2153 (6)	3.6 (2)
O1	0.4333 (5)	0.3414 (3)	0.4176 (4)	4.3 (1)
Se1	0.1261 (1)	0.2398 (1)	0.0537 (1)	4.1 (1)

Table 2. Geometric parameters (Å, °)

C2—C1	1.395 (9)	C8—C7	1.547 (8)
C6—C1	1.396 (8)	C9—C7	1.523 (8)
Se1—C1	1.888 (5)	C10—C7	1.552 (7)
C3—C2	1.408 (9)	N1—C10	1.323 (7)
C4—C3	1.358 (8)	O1—C10	1.259 (6)
C5—C4	1.399 (8)	N1—C11	1.491 (7)
C7—C6	1.548 (7)	Se1—N1	1.859 (5)
C6—C1—C2	121.9 (5)	C9—C7—C8	108.1 (5)
Se1—C1—C2	118.1 (4)	C10—C7—C6	108.2 (4)
Se1—C1—C6	120.0 (4)	C10—C7—C8	109.0 (5)
C3—C2—C1	118.5 (6)	C10—C7—C9	108.4 (4)
C4—C3—C2	120.1 (5)	N1—C10—C7	119.5 (5)
C5—C4—C3	121.0 (6)	O1—C10—C7	120.4 (4)
C6—C5—C4	121.1 (5)	O1—C10—N1	120.1 (5)
C5—C6—C1	117.2 (5)	C11—N1—C10	119.8 (5)
C7—C6—C5	120.8 (5)	Se1—N1—C10	124.2 (4)
C8—C7—C6	121.9 (5)	Se1—N1—C11	114.6 (4)
C9—C7—C6	110.6 (4)	N1—Se1—C1	95.2 (2)
C1—C6—C7—C10	-49.5 (5)	C10—N1—Se1—C1	-30.1 (4)
C6—C7—C10—N1	54.0 (6)	N1—Se1—C1—C6	32.9 (4)
C7—C10—N1—Se1	-10.6 (6)	Se1—C1—C6—C7	3.2 (5)

Data collection and reduction: Siemens software. Program used to solve structure: *SHELXS86* (Sheldrick, 1985). Program used to refine structure: *SHELX76* (Sheldrick, 1976). Program used to calculate Cremer & Pople (1975) parameters: *PUCK2* (Luger & Bülow, 1983). Molecular graphics: *PLUTO* (Motherwell & Clegg, 1976).

The authors thank the A. Natterman Research Laboratory, Köln, Germany, for fruitful discussion and M. M. Vermeire for his helpful assistance with the diffractometry measurements.

Lists of structure factors, anisotropic displacement parameters, H-atom coordinates and least-squares-planes data have been deposited with the IUCr (Reference: PA1088). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

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